

# Translational Engineering Forum

## Concluding lecture



Aalto-yliopisto  
Aalto-universitetet  
Aalto University

Ivan Vujaklija

01/12/2020

# Agenda

- Course wrap-up
- Final technical details

## Essential Questions

- What have we done?
- To what end?

## Objective

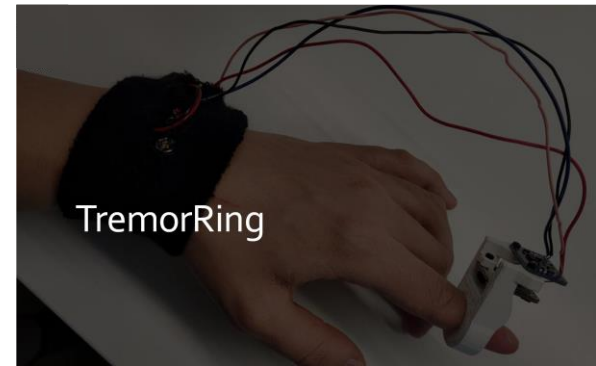
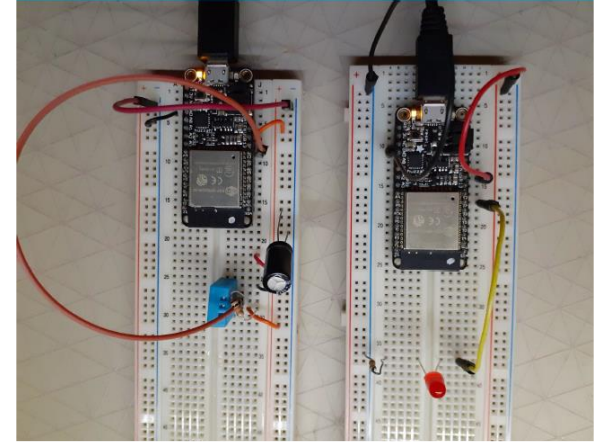
- Reflect on the course content
- Manage the future expectations
- Address any technical/content questions

# Translational Engineering Forum

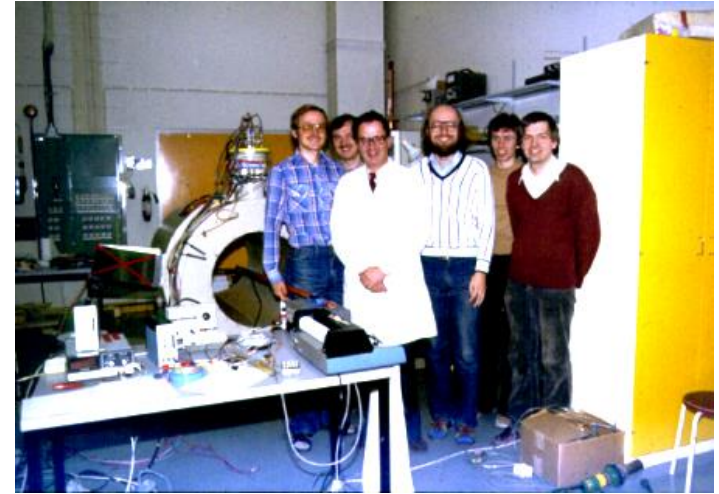
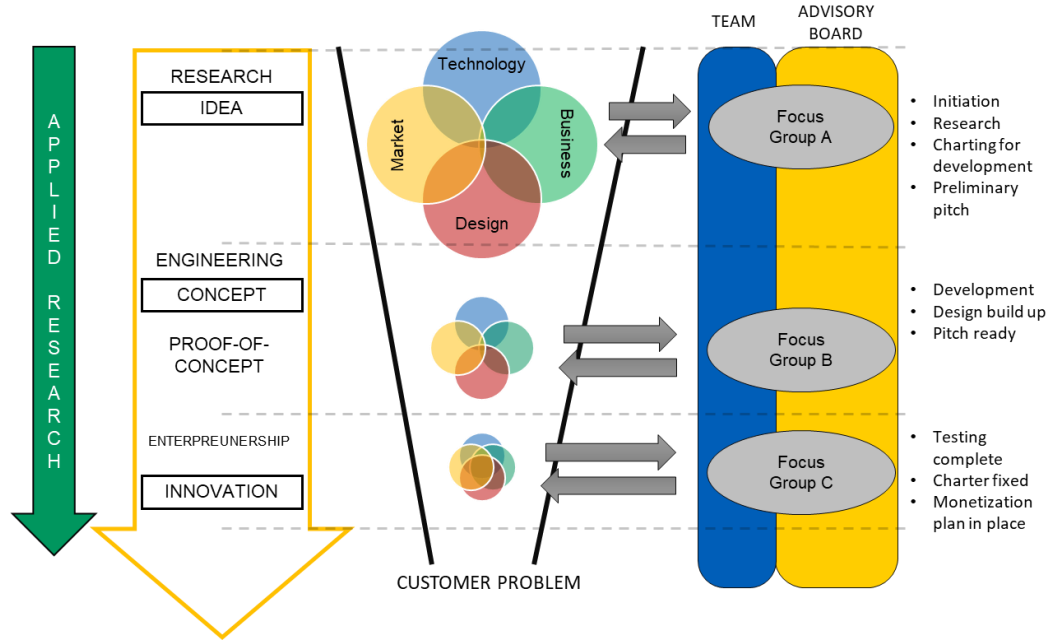
10 lectures

7 exercise sessions

4 guests in 3 forum sessions



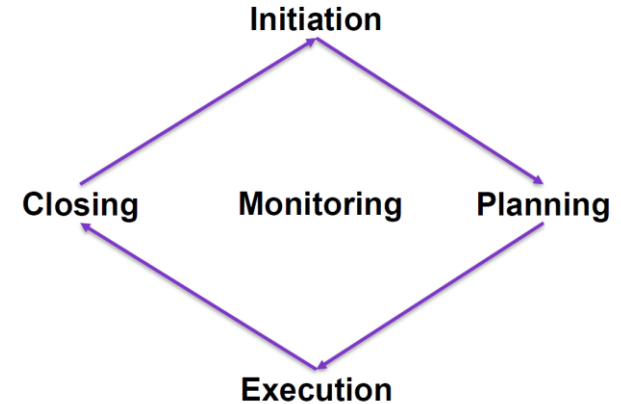
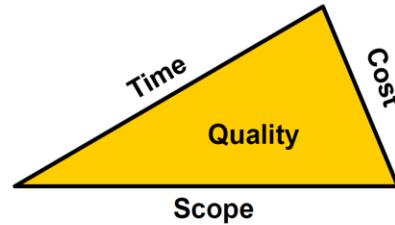
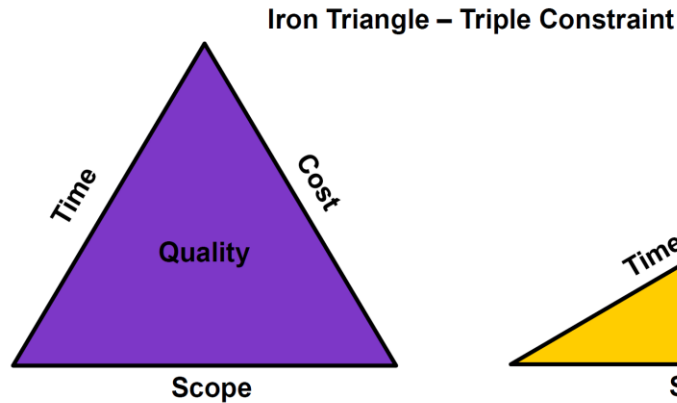
# 1. Introduction and local examples



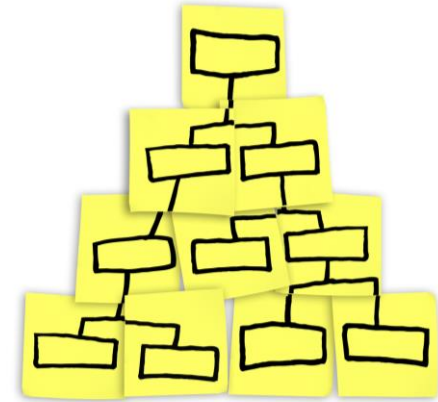
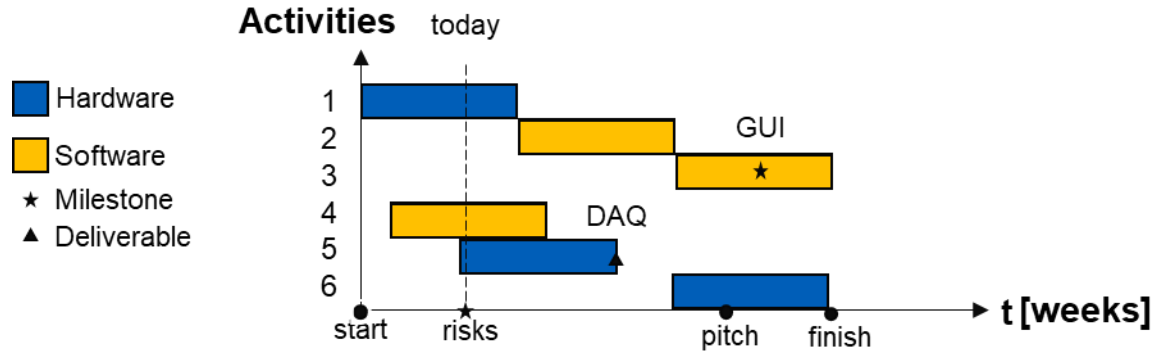
# 1. Introduction and local examples



# 2. Engineering project management



# 2. Engineering project management





# 3. Regulations, standards and certifications

- **Regulations** (regulatory compliance) describe the goal that organizations aspire to achieve in their efforts to ensure that they are aware of and take steps to comply with relevant laws, policies, and regulations
- **Standard** is a level of quality or achievement – instructions on how to handle regulatory compliance, providing a reminder of how compliance and risk should operate together
- **Certification** is an action or process of providing someone or something with an official document attesting to a status or level of achievement

CE

tukes

Turvallisuus- ja kemikaalivirasto





# 3. Regulations, standards and certifications

System/Function	Failure Mode	Failure Mode Effects	Severity	Potential Causes of the Failure Mode	Current Preventative Actions	Occurrence	Current Detection Activities	Detection	Priority
Sensing/Temperature	Doesn't do	<ul style="list-style-type: none"> <li>spoiled goods</li> <li>melting of the container insulation</li> <li>fire</li> </ul>	9	<ul style="list-style-type: none"> <li>sensor broken</li> <li>power down</li> </ul>	<ul style="list-style-type: none"> <li>sample testing</li> <li>casing design</li> <li>power control</li> </ul>	3	<ul style="list-style-type: none"> <li>spike detection</li> </ul>	7	7
	Measures wrong		9	<ul style="list-style-type: none"> <li>sensor broken</li> <li>calibration off</li> <li>reference voltage is off</li> </ul>	<ul style="list-style-type: none"> <li>sample testing</li> <li>casing design</li> <li>power control</li> <li>calibration (procedure and instruction)</li> </ul>	7	<ul style="list-style-type: none"> <li>calibration log</li> <li>calibration procedure</li> </ul>	3	5
Sensing/Humidity	Doesn't do	<ul style="list-style-type: none"> <li>spoiled goods</li> <li>creation of the mold</li> <li>short circuiting</li> </ul>	8	<ul style="list-style-type: none"> <li>sensor broken</li> <li>power down</li> </ul>	<ul style="list-style-type: none"> <li>sample testing</li> <li>casing design</li> <li>power control</li> </ul>	4	<ul style="list-style-type: none"> <li>spike detection</li> </ul>	7	6
	Measures wrong		7	<ul style="list-style-type: none"> <li>sensor broken</li> <li>calibration off</li> <li>reference voltage is off</li> </ul>	<ul style="list-style-type: none"> <li>sample testing</li> <li>casing design</li> <li>power control</li> <li>calibration (procedure and instruction)</li> </ul>	7	<ul style="list-style-type: none"> <li>calibration log</li> <li>calibration procedure</li> </ul>	2	4
Actuation/Fan	Dies	<ul style="list-style-type: none"> <li>spoiled goods</li> <li>melting of the container insulation</li> <li>fire</li> </ul>	9	<ul style="list-style-type: none"> <li>relay broken (voltage)</li> <li>controller broken</li> <li>fan broken</li> </ul>	<ul style="list-style-type: none"> <li>sample testing</li> <li>smooth start/stop</li> <li>power control</li> </ul>	4	<ul style="list-style-type: none"> <li>energy consumption monitor</li> </ul>	5	10
	Runs too fast/slow	<ul style="list-style-type: none"> <li>spoiled goods</li> <li>too dry/humid</li> <li>mechanical damage</li> </ul>	8	<ul style="list-style-type: none"> <li>relay broken (current)</li> <li>controller broken</li> </ul>	<ul style="list-style-type: none"> <li>sample testing</li> <li>smooth start/stop</li> <li>circuit design</li> <li>power control</li> </ul>	5	<ul style="list-style-type: none"> <li>spike detection</li> </ul>	2	7

For each **Failure effect** rate its **user impact**:

- *Minimal* system effect – user is unaware
- *Slight* reduction in performance – user notices
- *Noticeable* drop in performance – user is disappointed
- *Part* of the system is *inoperable* – user is annoyed
- Failure *compromises user safety* or regulations

List **how you will prevent** each failure cause:

- Planned analysis
- Preliminary testing

Rate how likely it is for this cause to occur:

- (1) *Remote* – not really anticipated (1:1.000.000)
- (2) *Very low* – only under extreme circumstances (1:100.000)
- (3-4) *Low* – isolated cases (1:30.000 or 1:1000)
- (5-6) *Moderate* – occasionally (0,5%-2%)
- (7-8) *High* – often (12-15%)
- (9-10) *Very high* – it is bound to happen (>33%)

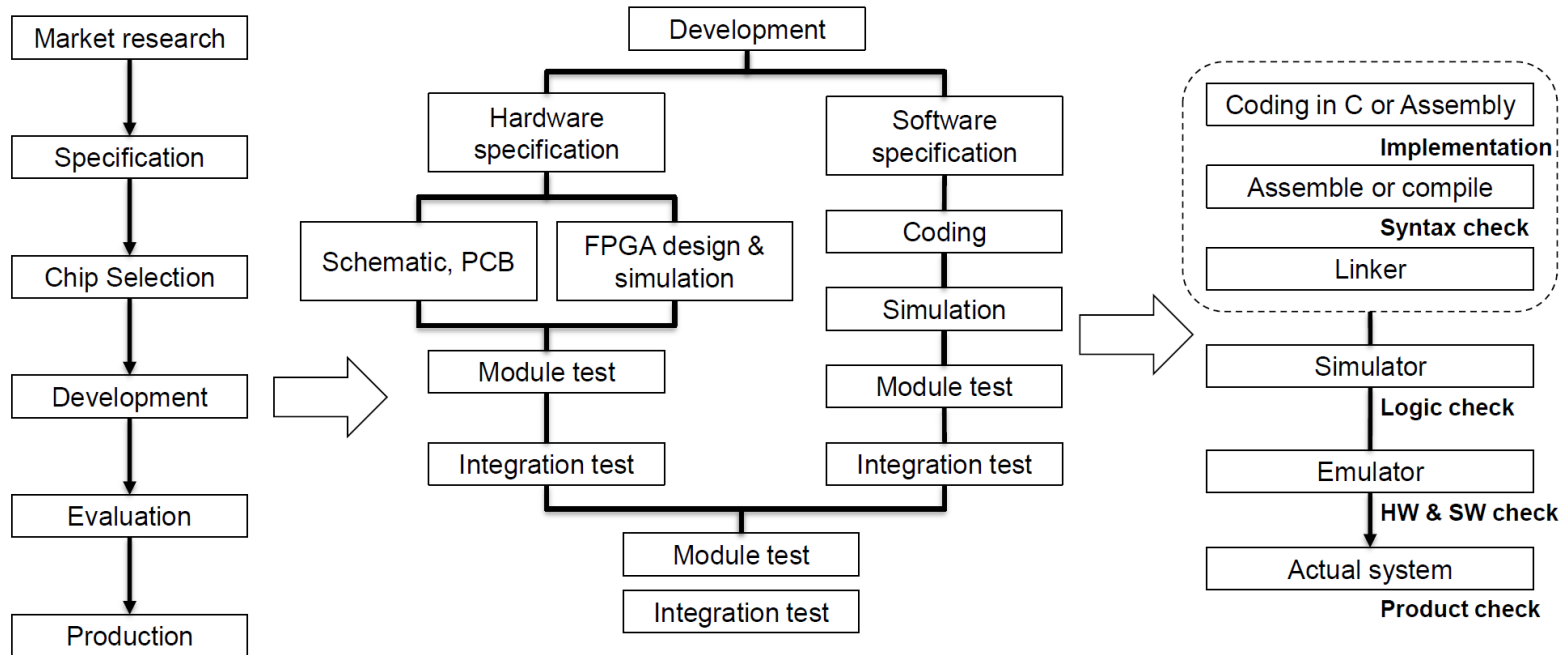
List how you **plan to detect** each failure cause:

- Customer reviews
- Final testing

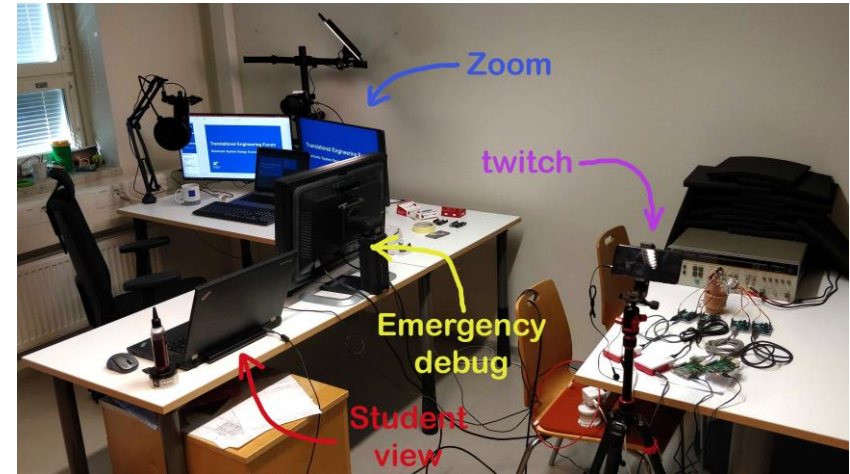
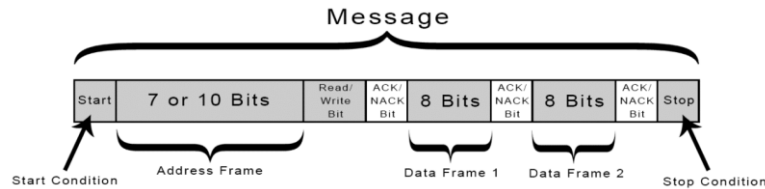
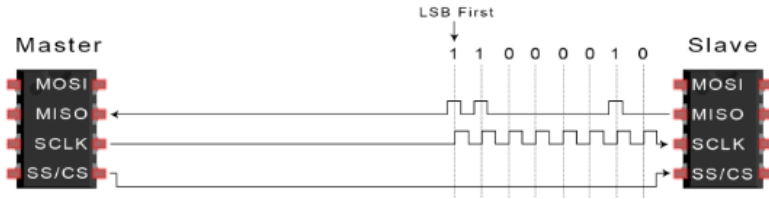
Rate how likely it is to detect this cause :

- (1-2) *Very low* – Unlikely
- (3-4) *Low* – Poor chance of detection
- (5-6) *Moderate* – Might detect it
- (7-8) *High* – Good chance of detection
- (9-10) *Very high* – Almost certain detection

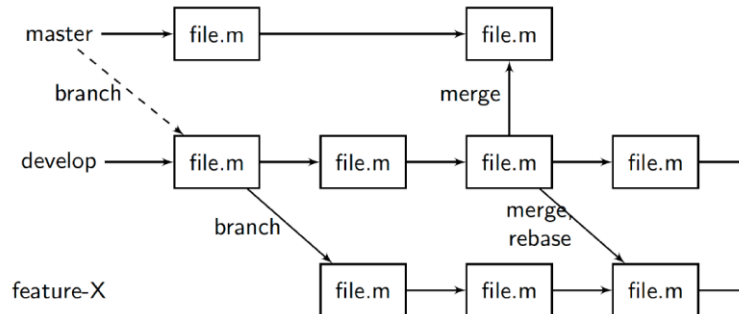
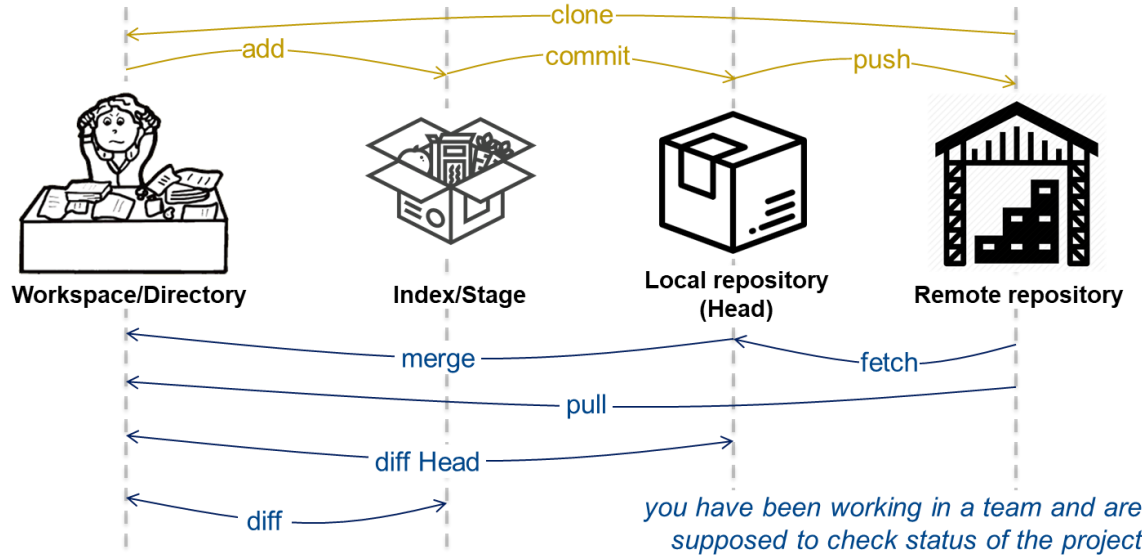
# 4. (Embedded) Electronic system design



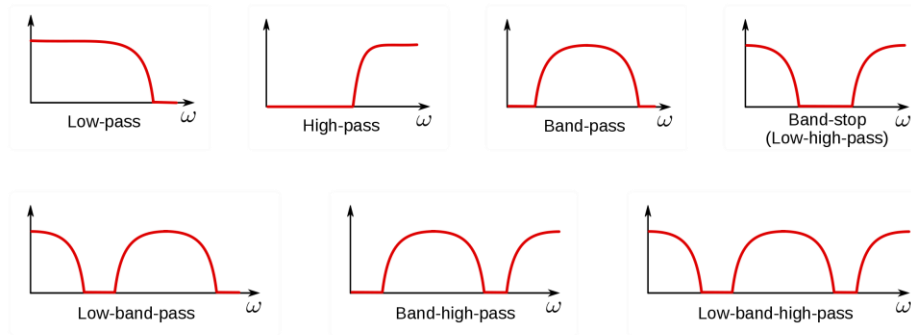
# 4. (Embedded) Electronic system design



# 5. Software engineering



# 5. Software engineering & signal processing

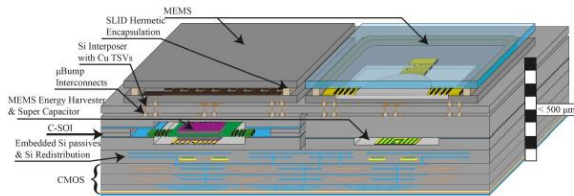


```
L = 5; %filter length
B = ones(1,L)/L; % [0.2, 0.2, 0.2, 0.2, 0.2] numerator coefficients
A = [1]; %denominator coefficients
x = rand(1,10); %random samples for x;
y = filter(B,A,x); %filter input x and get result in y
```

# 6. MEMS and electronics integration

Prof. Mervi Paulasto-Kröckel

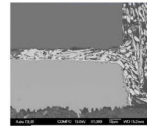
## Other assembly processes



Concept for standalone sensor system

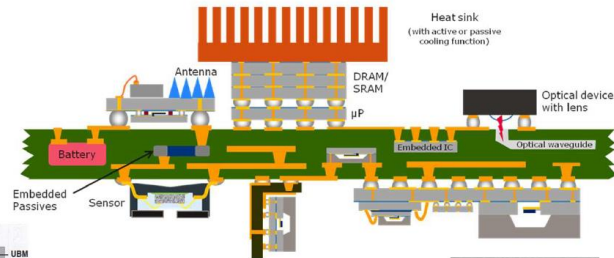
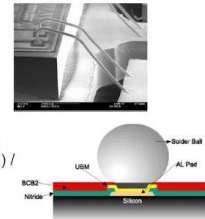
Die attach to substrate/leadframe:

Integrated circuit	Silicon, GaAs,...
Adhesion layer	Ti, TiW, Cr,...
Barrier layer	Ni, NiV, Ni(P), Co, Co(P), NiCo,...
Oxidation protection layer	Au, Pt,...
Die attach material	AuSn20, PbSn10, Ag-epoxy, Ag-glass,...
Substrate metallization	ENIG, ENEPIG, Cu/OSP, Cu/Sn, CuAg,...



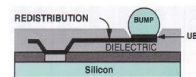
Die electrical interconnections:

- Wire bonding; Al, Cu, Au
- Flip chip; SnAgCu (SAC), SnAg including UBM adhesive (e.g. TiW) / barrier (e.g. Ni) / inertness (e.g. Au)
- $\mu$ bump; Cu pillar + SnAg/SAC



Substrate integration:

- PCB laminates, glass epoxy FR4 core – Cu (+HDI)
- Chip embedding
- Flex PCB, polyimide – Cu
- Printed electronics
- Ceramic substrates, Al<sub>2</sub>O<sub>3</sub>, AlN, Direct-Copper-Bonded (DCB)

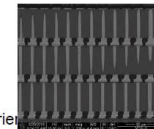


Encapsulation/protection:

- Mold compounds; SiO<sub>2</sub>-filled epoxies
- Underfills
- Redistribution of electrical I/Os; BCB, PI
- Conformal coatings, silicone

Die-to-die interconnections:

- Through silicon via (TSV)
- Cu or poly-Si
- Insulation (e.g. SiO<sub>2</sub>) / barrier (e.g. TaN) / metallization layers (Ru, Cu)

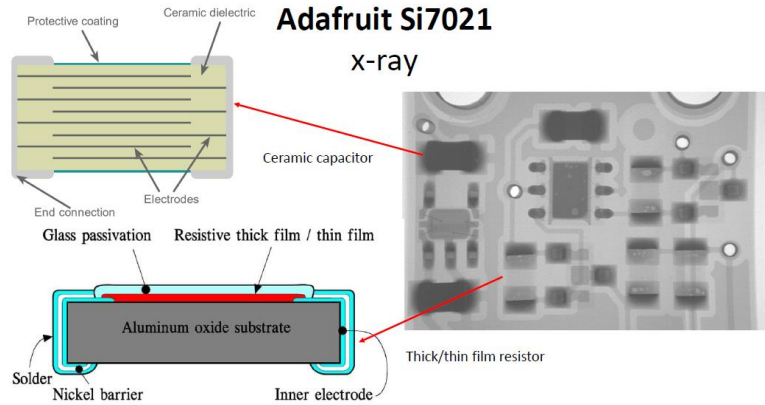


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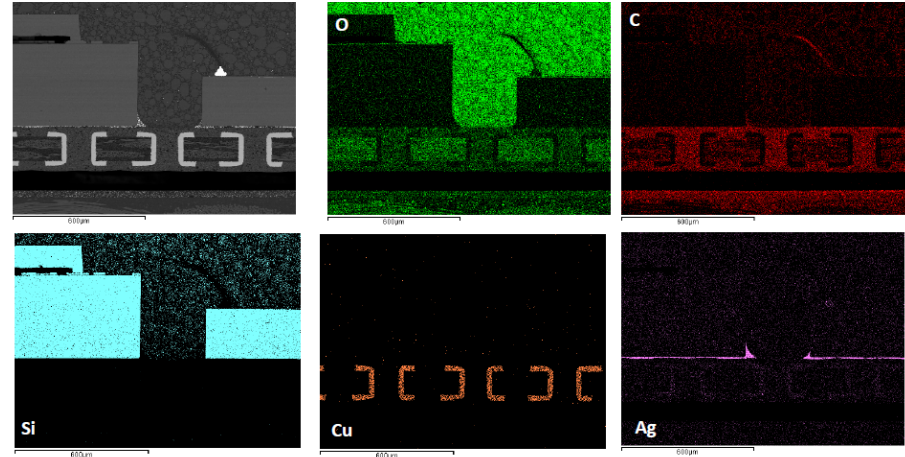


# 6. MEMS and electronics integration

Dr. Vesa Vuorinen



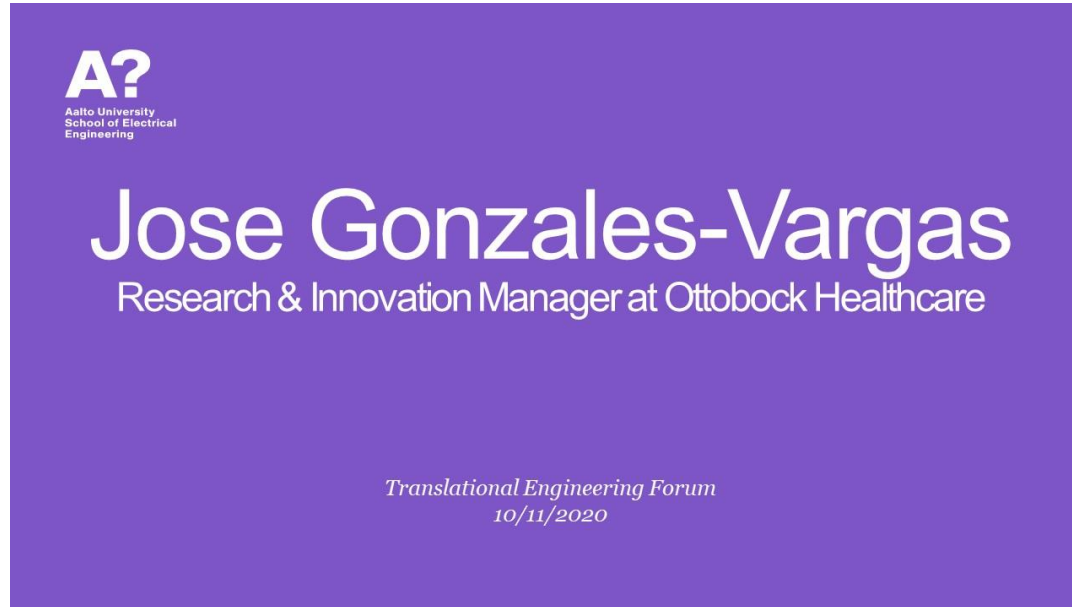
**ADXL345 3-axis accelerometer**





# Forum

# 7. Forum 1



**A?**  
Aalto University  
School of Electrical  
Engineering

## Jose Gonzales-Vargas

Research & Innovation Manager at Ottobock Healthcare

*Translational Engineering Forum*  
10/11/2020

# 8. Forum 2



Aalto University  
School of Electrical  
Engineering

## Irene Mendez Guerra & Ben Lakey

CTO and CEO at Naviga

*Translational Engineering Forum*  
17/11/2020

# 9. Forum 3



Milan Pešić

Manager Device and Technology Development  
at Applied Materials

*Translational Engineering Forum  
24/11/2020*

# To what end?

# Now you hopefully:

- Understand the process and requirements to convert basic research into innovative products and technologies
- Apply the process of demand-based product development
- Define core knowledge and skills needed to design multidisciplinary technical products
- Design a concept for an electronic device and anticipate main challenges in the entity including SW/HW interfaces, EMC, assembly and manufacturing
- Identify processes needed for quality assurance in product development

# So you can:

- Start more comprehensive projects
- Initiate new ventures within your area of expertise and interest
- Have more complete understanding of engineering activities and their impact
- Be more competitive and have a greater understanding of your own work
- Have easier time in other courses

A high-angle, slightly blurred photograph of a very cluttered electronics workshop or lab. The workbench is covered with a dense array of electronic components, including resistors, capacitors, integrated circuits, and various wires. Tools like pliers, a soldering iron, and a multimeter are visible. In the background, there are shelves with more components and a pegboard with hanging tools. A brown office chair is positioned in the lower right foreground. The overall scene conveys a sense of intense, hands-on technical work.

# Comments/reflections/ suggestions?



# Final group report

# Deadline **01/12** 23:59

This is an extension of your previous report. Therefore, apart from new content it should also account for provided comments.

There is no predefined format of the report as projects are highly individual, but it should still somehow convey at least the following:

*Background research / introduction of the problem, Description of the team and individual roles, Project charter (objectives, stakeholders, timeline, communication plan, ...), sensor consideration, System design, Legislative considerations (regulations, standards and certifications), Upscaling plan*

Reports will be evaluated based on their: technical content, clarity and style of writing, organization, implementation of the methods covered in the course

Short written feedback will be provided within the two weeks from each submission.

To be submitted through MyCourses (Assignments) as a PDF named:

[GroupNumber\\_GroupReport-ReportNumber-2020.pdf](#)

# Final peer evaluation

# Deadline **06/12** 23:59

Send score sheets via email directly to [ivan.vujaklija@aalto.fi](mailto:ivan.vujaklija@aalto.fi)

Students should evaluate (0-5) their own efforts as well as their group peers by filling in the following table on two occasions.

The peer evaluation will be **fully anonymous**, and each student will communicate these directly with the instructor.

One week following each submission students will receive the average of all grades.

**Do not submit uncontested grading!**

	Self	Peer 1	Peer 2	...	Peer N
Reaching goals					
Meeting deadlines					
Participation in group work					
Commitment					
Quality					
Proactivity					
Learning					



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# Thank you!

## Online Course Feedback